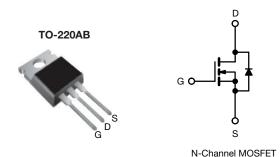
Vishay Siliconix

COMPLIANT

HALOGEN

FREE

E Series Power MOSFET



PRODUCT SUMMARY		
V_{DS} (V) at T_J max.	65	50
R _{DS(on)} typ. (Ω) at 25 °C	V _{GS} = 10 V	0.043
Q _g max. (nC)	13	30
Q _{gs} (nC)	2	5
Q _{gd} (nC)	1	9
Configuration	Sin	gle

FEATURES

- 4th generation E series technology
- Low figure-of-merit (FOM) Ron x Qg
- Low effective capacitance (Co(er))
- · Reduced switching and conduction losses
- Avalanche energy rated (UIS)
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>

APPLICATIONS

- · Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
 - High-intensity discharge (HID)
 - Fluorescent ballast lighting
- Industrial
 - Welding
 - Induction heating
 - Motor drives
 - Battery chargers
 - Solar (PV inverters)

ORDERING INFORMATION	
Package	TO-220AB
Lead (Pb)-free and halogen-free	SiHP050N60E-GE3

ABSOLUTE MAXIMUM RATINGS (T _C	= 25 °C, unl	ess otherwis	se noted)		
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-source voltage		V_{DS}	600	V	
Gate-source voltage			V_{GS}	± 30	7 v
Continuous drain surrent /T 150 °C)	\/ at 10.\/	$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$	1	51	
Continuous drain current (T _J = 150 °C)	V _{GS} at 10 V	T _C = 100 °C	- I _D	32	Α
Pulsed drain current ^a			I _{DM}	155	
Linear derating factor				2.2	W/°C
Single pulse avalanche energy b		E _{AS}	427	mJ	
Maximum power dissipation		P _D	278	W	
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +150	°C	
Drain-source voltage slope		T _J = 125 °C	dv/dt	70	1//20
Reverse diode dv/dt ^d		av/at	50	V/ns	
Soldering recommendations (peak temperature) c For 10 s		10 s		260	°C

Notes

- Initial samples marked as "SiHP50N60E"
- a. Repetitive rating; pulse width limited by maximum junction temperature
- b. V_{DD} = 120 V, starting T_J = 25 °C, L = 28.2 mH, R_g = 25 Ω , I_{AS} = 5.5 A
- c. 1.6 mm from case
- d. $I_{SD} \le I_D$, di/dt = 100 A/µs, starting $T_J = 25$ °C



Vishay Siliconix

THERMAL RESISTANCE RATI	NGS			
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum junction-to-ambient	R_{thJA}	-	62	°C/W
Maximum junction-to-case (drain)	R_{thJC}	-	0.45	C/VV

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-source breakdown voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		600	-	-	V
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I _D = 1 mA	-	0.60	-	V/°C
Gate-source threshold voltage (N)	V _{GS(th)}	V _{DS} =	· V _{GS} , I _D = 250 μA	3.0	-	5.0	V
Cata assuma laglanda		,	$V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA
Gate-source leakage	I_{GSS}	,	$V_{GS} = \pm 30 \text{ V}$	-	-	± 1	μΑ
Zoro goto voltago droin ourrent	1	V _{DS} =	600 V, V _{GS} = 0 V	-	-	1	
Zero gate voltage drain current	I _{DSS}	V _{DS} = 480 V	, V _{GS} = 0 V, T _J = 125 °C	-	-	10	μA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 23 A	-	0.043	0.050	Ω
Forward transconductance ^a	9 _{fs}	V _{DS}	= 20 V, I _D = 23 A	-	12	-	S
Dynamic							
Input capacitance	C _{iss}	$V_{GS} = 0 V$,		-	3459	-	pF
Output capacitance	C _{oss}	Ţ ,	V _{DS} = 100 V,		148	-	
Reverse transfer capacitance	C _{rss}	f = 1 MHz		-	7	-	
Effective output capacitance, energy related ^a	C _{o(er)}	V 0V/1 400V/V 0V		-	114	-	
Effective output capacitance, time related ^b	$C_{o(tr)}$	V _{DS} = 0 V	$V_{DS} = 0 \text{ V to } 480 \text{ V}, V_{GS} = 0 \text{ V}$		706	-	
Total gate charge	Qg			-	65	130	
Gate-source charge	Q_{gs}	$V_{GS} = 10 \text{ V}$	$I_D = 23 \text{ A}, V_{DS} = 480 \text{ V}$	-	25	-	nC
Gate-drain charge	Q_gd			-	19	-	
Turn-on delay time	$t_{d(on)}$	V _{DD} = 480 V, I _D = 23 A,		-	35	70	
Rise time	t _r			-	82	164	ne
Turn-off delay time	$t_{d(off)}$	V _{GS} =	$V_{GS} = 10 \text{ V}, R_g = 9.1 \Omega$		67	134	ns
Fall time	t _f	1		-	48	96	
Gate input resistance	R_g	f = 1	MHz, open drain	0.43	0.85	1.72	Ω
Drain-Source Body Diode Characteristic	s						
Continuous source-drain diode current	I _S	showing the			-	50	
Pulsed diode forward current	I _{SM}	integral reverse p - n junction diode		-	-	155	A
Diode forward voltage	V _{SD}	T _J = 25 °C	C, I _S = 23 A, V _{GS} = 0 V	-	-	1.2	V
Reverse recovery time	t _{rr}			-	435	870	ns
Reverse recovery charge	Q _{rr}	$T_J = 25$ °C, $I_F = I_S = 23$ A, di/dt = 100 A/ μ s, $V_R = 400$ V		-	9.2	18.4	μC
Reverse recovery current	I _{RRM}			-	39	-	Α

Notes

- a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS}
- b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS}



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

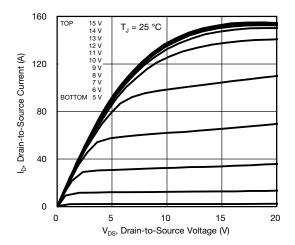


Fig. 1 - Typical Output Characteristics

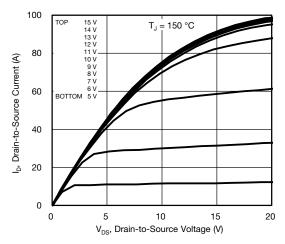


Fig. 2 - Typical Output Characteristics

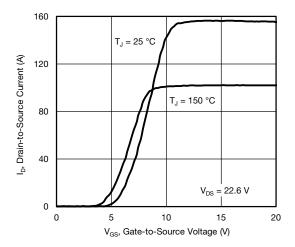


Fig. 3 - Typical Transfer Characteristics

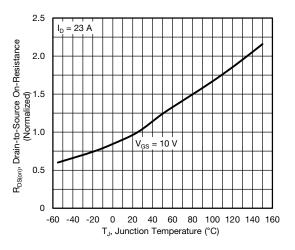


Fig. 4 - Normalized On-Resistance vs. Temperature

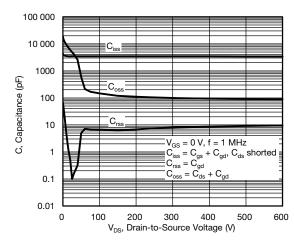


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

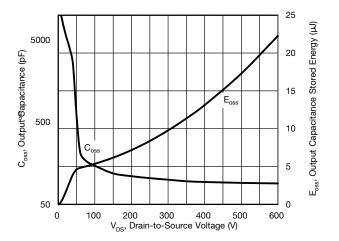


Fig. 6 - C_{oss} and E_{oss} vs. V_{DS}

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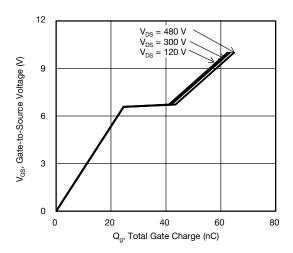


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

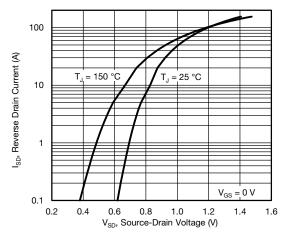


Fig. 8 - Typical Source-Drain Diode Forward Voltage

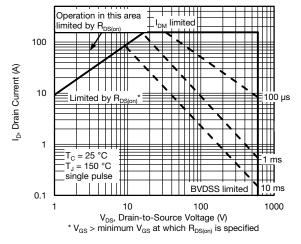


Fig. 9 - Maximum Safe Operating Area

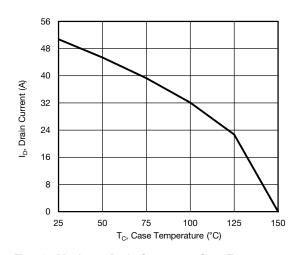


Fig. 10 - Maximum Drain Current vs. Case Temperature

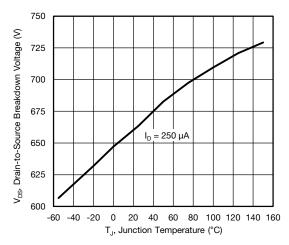


Fig. 11 - Temperature vs. Drain-to-Source Voltage



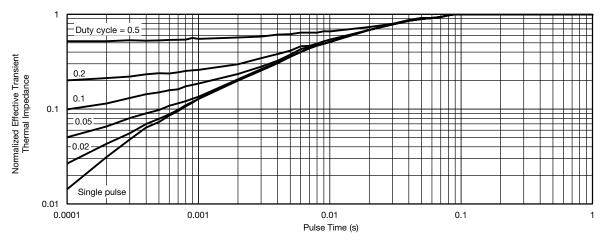


Fig. 12 - Normalized Transient Thermal Impedance, Junction-to-Case

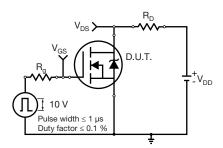


Fig. 13 - Switching Time Test Circuit

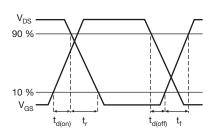


Fig. 14 - Switching Time Waveforms

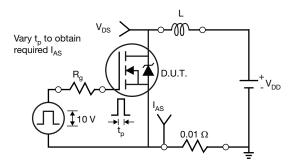


Fig. 15 - Unclamped Inductive Test Circuit

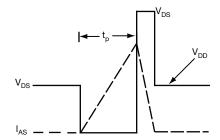


Fig. 16 - Unclamped Inductive Waveforms

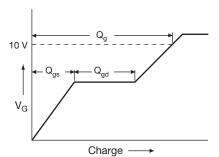


Fig. 17 - Basic Gate Charge Waveform

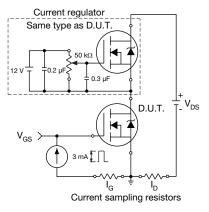
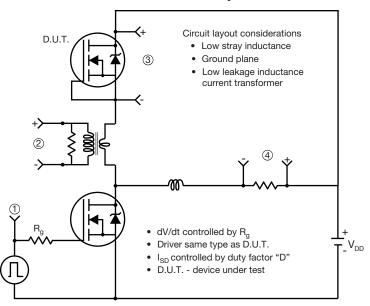


Fig. 18 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



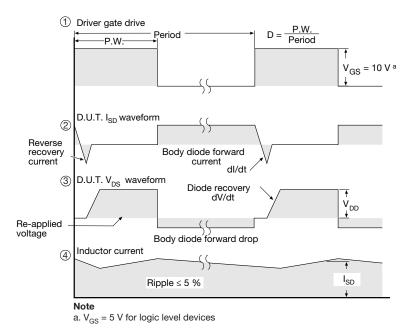


Fig. 19 - For N-Channel

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TO-220-1



DIM.	MILLIM	METERS	INCHES		
	MIN.	MAX.	MIN.	MAX.	
Α	4.24	4.65	0.167	0.183	
b	0.69	1.02	0.027	0.040	
b(1)	1.14	1.78	0.045	0.070	
С	0.36	0.61	0.014	0.024	
D	14.33	15.85	0.564	0.624	
E	9.96	10.52	0.392	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.10	6.71	0.240	0.264	
J(1)	2.41	2.92	0.095	0.115	
L	13.36	14.40	0.526	0.567	
L(1)	3.33	4.04	0.131	0.159	
ØP	3.53	3.94	0.139	0.155	
Q	2.54	3.00	0.100	0.118	

Note

DWG: 6031

• $M^* = 0.052$ inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



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Vishay

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